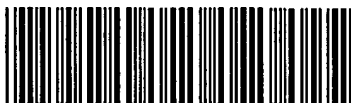


Search Notes

Application/Control No.

10/623,232

Examiner

M. Lee

Applicant(s)/Patent under
Reexamination

RENNER ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	531	5/4/2006	ML
	530		
	525		
	540		
	541		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/4/2006	ML